- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

The '279 offers 4 basic $\overline{S} \cdot \overline{R}$ flip-flop latches in one 16-pin, 300-mil package. Under conventional operation, the $\overline{S} \cdot \overline{R}$ inputs are normally held high. When the \overline{S} input is pulsed low, the Q output will be set high. When \overline{R} is pulsed low, the Q output will be reset low. Normally, the $\overline{S} \cdot \overline{R}$ inputs should not be taken low simultaneously. The Q output will be unpredictable in this condition.

FUNCTION TABLE (each latch)

INP	UTS	OUTPUT
St	R	a
н	Н	α ₀
L	Н	н
н	L	L
L	L	Н‡

H = high level

L = low level

†For latches with double S inputs:

 Q_0 = the level of Q before the indicated input conditions were established.

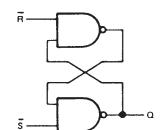
 $H = both \overline{S}$ inputs high

L = one or both \$\overline{S}\$ inputs low

logic diagram (positive logic)

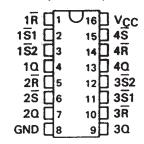
Ī O

(latches 1 and 3)

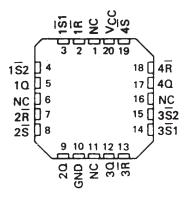


(latches 2 and 4)

SN54279, SN54LS279A . . . J OR W PACKAGE SN74279 . . . N PACKAGE SN74LS279A . . . D OR N PACKAGE (TOP VIEW)

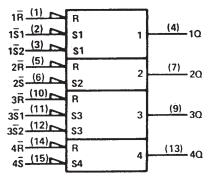


SN54LS279A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic symbol§



[§]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

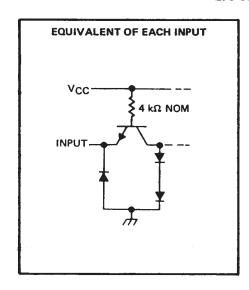
Pin numbers shown are for D, J, N, and W packages.

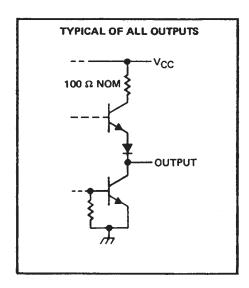
 $^{^\}ddagger$ This configuration is nonstable: that is, it may not persist when the \overline{S} and \overline{R} inputs return to their inactive (high) level.

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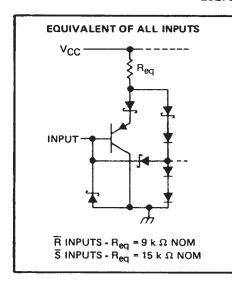
schematics of inputs and outputs

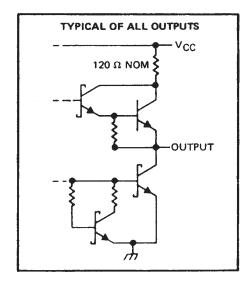
279 CIRCUITS





'LS279A CIRCUITS





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	7 V
Input voltage: '279	5.5 V
' LS279A	7 V
Operating free-air temperature range: SN54' TYPES	55° C to 125° C
SN74' TYPES	0° C to 70° C
Storage temperature range	65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.



recommended operating conditions

			SN54279			SN74279			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.8		-	0.8	V	
ЮН	High-level output current			- 0.8			- 0.8	mA	
IOL	Low-level output current			16			16	mA	
tw	Pulse duration, low	20			20			กร	
TA	Operating free-air temperature	- 55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER VIK	TEST CONDITIONS †				SN54279			SN74279			
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
	VCC = MIN,	I _I = - 12 mA				– 1.5			- 1.5	V	
Voн	V _{CC} = MIN,	V _{IL} = 0.8 V,	1 _{OH} = - 0.8 mA	2.4	3.4		2.4	3.4		V	
VOL	V _{CC} = MIN,	V _{1H} = 2 V,	1 _{OL} = 16 mA		0.2	0.4		0.2	0.4	V	
11	V _{CC} = MAX,	V _I = 5.5 V				1			1	mA	
Чн	V _{CC} = MAX,	V ₁ = 2.4 V				40			40	μΑ	
IIL	V _{CC} = MAX,	V ₁ = 0.4 V				- 1.6			- 1.6	mA	
I _{OS} \$	V _{CC} = MAX			- 18		- 55	- 18		- 57	mA	
1cc	V _{CC} = MAX,	See Note 2			18	30		18	30	mΑ	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: I_{CC} is measured with all R inputs grounded, all S inputs at 4.5 V, and all outputs open.

switching characteristics, VCC = 5 V, TA = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	IDITIONS	MIN	TYP	MAX	UNIT
^t PLH	5	0				12	22	ns
t _{PHL}	3	<u> </u>	$R_{L} = 400 \Omega$,	C ₁ = 15 pF		9	15	113
tPHL	Ř	Q	<u> </u>			15	27	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



^{\$} All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ} \text{C}$.

Not more than one output should be shorted at a time.

SN54279, SN54LS279A, SN74279, SN74LS279A QUADRUPLE \overline{S} - \overline{R} LATCHES

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recommended operating conditions

		St	SN54LS279A			SN74LS279A			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4,75	5	5.25	٧	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.7			0.8	V	
Іон	High-level output current			0.4			- 0.4	mA	
IOL	Low-level output current			4			8	mA	
t _W	Pulse duration, low	20			20			ns	
TA	Operating free-air temperature	– 55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		SN54LS279A			SN	UNIT			
		1521 CONDIT	IUNS	MIN	TYP#	MAX	MIN	TYP‡	MAX	UNIT
VIK	V _{CC} = MIN, I _I = - 18 mA								- 1.5	V
Voн	V _{CC} = MIN,	VIL = MAX,	I _{OH} = 0.4 mA	2.5	3.4		2.7	3.4		V
V	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 4 mA		0.25	0.4		0.25	0.4	V
VOL	V _{CC} = MIN,	V _{1H} = 2 V,	IOL = 8 mA					0.25	0.5	
11	V _{CC} = MAX,	V ₁ = 7 V				0.1			0.1	mA
Чн	V _{CC} = MAX,	V ₁ = 2.7 V				20			20	μΑ
I _I Γ	V _{CC} = MAX,	V ₁ = 0.4 V				- 0.2			- 0.2	mA
IOS §	V _{CC} = MAX			- 20		- 100	- 20		- 100	mA
¹cc	V _{CC} = MAX,	See note 2			3.8	7		3.8	7	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: I_{CC} is measured with all R inputs grounded, all S inputs at 4.5 V, and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST COM	MIN	TYP	MAX	UNIT	
^t PLH	_	0				12	22	ns
^t PHL	3	4	$R_L = 2 k\Omega$,	$C_L = 15 pF$		13	21	113
tPHL	Ā	Q				15	27	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ} \text{C}$.

[§] Not more than one output should be shorted at a time, and the duration of the short-circuit should be less than one second.

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